Notice of References Cited Application/Control No. 10/555,445 Examiner KATELYN WHATLEY Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | Α | US-7,380,423 | 06-2008 | Musone, John P. | 68/20 |
| * | В | US-2005/0132503 | 06-2005 | Yang et al. | 008/149.3 |
| * | O | US-2004/0187527 | 09-2004 | Kim et al. | 068/005.00C |
| * | D | US-2001/0049847 | 12-2001 | Yarmosky, Steven E. | 8/158 |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Ι | US- | | | |
| | _ | US- | | | |
| | 7 | US- | | | |
| | K | US- | | | |
| | ┙ | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | Р | | | | | |
| | Ø | | | | | |
| | R | | | | | |
| | Ø | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|----------|---|
| | U | |
| | V | |
| | w | |
| | х | |

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